

## Description

The AFBR-5100Z family of transceivers from Agilent Technologies provide the system designer with products to implement a range of FDDI and ATM (Asynchronous Transfer Mode) designs at the $100 \mathrm{Mbps} / 125 \mathrm{MBd}$ rate.

The transceivers are all supplied in the new industry standard 1x9 SIP package style with either a duplex SC or a duplex $\mathrm{ST}^{*}$ connector interface.

FDDI PMD, ATM and Fast Ethernet 2000 m Backbone Links

The AFBR-5103Z/-5103TZare 1300 nm products with optical performance compliant with the FDDI PMD standard. The FDDI PMD standard is ISO/ IEC 9314-3:
1990 and ANSI X3.166-1990.
These transceivers for 2000 meter multimode fiber backbones are supplied in the small 1x9 duplex SC or ST package style for those designers who want to avoid the larger MIC/R (Media Interface Connector/ Receptacle) defined in the FDDI PMD standard.

# Agilent AFBR-5103Z -5103TZ 1300 nm 2000 m AFBR-5103AZ/ -5103ATZ 5103PZ -5103PEZ FDDI, 100 M bps ATM, and Fast Ethernet Transceivers in Low Cost 1x9 Package Style Data Sheet 



Agilent Technologies also provides several other FDDI products compliant with the PMD and SM-PMD standards. These products are available with MIC/R, $\mathrm{ST}^{\odot}$ and FC connector styles. They are available in the 1 x13 and $2 \times 11$ transceiver and 16 pin transmitter/receiver package styles for those designs that require these alternate configurations.

The AFBR-5103Z/-5103TZ is also useful for both ATM 100 Mbps interfaces and Fast Ethernet 100 Base-FX interfaces. The ATM Forum User-Network Interface (UNI) Standard, Version 3.0, defines the Physical Layer for 100 Mbps Multimode Fiber Interface for ATM in Section 2.3 to be the FDDI PMD Standard. Likewise, the Fast Ethernet Alliance defines the Physical Layer for 100 BaseFX for Fast Ethernet to be the FDDI PMD Standard.

Features

- Full Compliance with the Optical Performance Requirements of the FDDI PMD Standard
- Full Compliance with the FDDI LCF-PM D Standard
- Full Compliance with the Optical Performance Requirements of the ATM 100 Mbps Physical Layer
- Full Compliance with the Optical Performance Requirements of 100 Base-FX Version of IEEE 802.3u
- M ultisourced 1x9 Package Style with Choice of Duplex SC or Duplex ST* Receptacle
- Wave Solder and Aqueous Wash Process Compatible
- RoHS Compliance


## Applications

- M ultimode Fiber Backbone Links
- M ultimode Fiber Wiring Closet to Desktop Links
- Multimode Fiber M edia Converter

Note: The " $T$ " in the product numbers indicates a transceiver with a duplex ST connector receptacle. Product numbers without a "T" indicate transceivers with a duplex SC connector receptacle.

ATM applications for physical layers other than 100 Mbps Multimode Fiber Interface are supported by Agilent. Products are available for both the single mode and the multimode fiber SONET-OC-3C (STS-3C) ATM interface and the 155 Mbps ATM 94 MBd multimode fiber ATM interface as specified in the ATM Forum UNI.

## Transmitter Sections

The transmitter sections of the AFBR-5103Z series utilize 1300 nm Surface Emitting InGaAsP LEDs. These LEDs are packaged in the optical subassembly portion of the transmitter section. They are driven by a custom silicon IC which converts differential PECL logic signals, ECL referenced (shifted) to a +5 Volt supply, into an analog LED drive current.

## Receiver Sections

The receiver sections of the AFBR-5103Z series utilize InGaAs PIN photodiodes coupled to a custom silicon transimpedance preamplifier IC. These are packaged in the optical subassembly portion of the receiver.

These PIN/preamplifier combinations are coupled to a custom quantizer IC which provides the final pulse shaping for the logic output and the Signal Detect function. The data output is differential. The signal detect output is single-ended. Both data and signal detect outputs are PECL compatible, ECL referenced (shifted) to $\mathrm{a}+5$ Volt power supply.

## Package

The overall package concept for the Agilent transceivers consists of the following basic elements; two optical subassemblies, an electrical subassembly and the housing as illustrated in Figure 1 and Figure 1a.

Figure 2b shows the outline drawing for options that include mezzanine height with extended shield.

The package outline drawing and pin out are shown in Figures 2, 2a and 3. The details of this package outline and pin out are compliant with the multisource definition of the 1 x 9 SIP. The low profile of the Agilent transceiver design complies with the maximum height allowed for the duplex SC connector over the entire length of the package.

The optical subassemblies utilize a high volume assembly process together with low cost lens elements which result in a cost effective building block.

The electrical subassembly consists of a high volume multilayer printed circuit
board on which the IC chips and various surface-mounted passive circuit elements are attached.

The package includes internal shields for the electrical and optical subassemblies to ensure low EMI emissions and high immunity to external EMI fields.

The outer housing including the duplex SC connector receptacle or the duplex ST ports is molded of filled nonconductive plastic to provide mechanical strength and electrical isolation. The solder posts of the Agilent design are isolated from the circuit design of the transceiver and do not require connection to a ground plane on the circuit board.

The transceiver is attached to a printed circuit board with the nine signal pins and the two solder posts which exit the bottom of the housing. The two solder posts provide the primary mechanical strength to withstand the loads imposed on the transceiver by mating with duplex or simplex SC or ST connectored fiber cables.


Figure 1. SC Block Diagram


TOP VIEW
Figure 1a. ST Block Diagram.


Figure 2. Package Outline Drawing with Standard Height.


Figure 2a. ST Package Outline Drawing with Standard Height.


Figure 2b. Package Outline Drawing - Mezzanine Height with Extended Shield.


Figure 3. Pin Out Diagram.

## Application Information

The Applications Engineering group in the Agilent Optical Communication Division is available to assist you with the technical understanding and design trade-offs associated with these transceivers. You can contact them through your Agilent sales representative.

The following information is provided to answer some of the most common questions about the use of these parts.

## Transceiver Optical Pow er Budget versus Link Length

Optical Power Budget (OPB) is the available optical power for a fiber optic link to accommodate fiber cable losses plus losses due to in-line connectors, splices, optical switches, and to provide margin for link aging and unplanned losses due to cable plant reconfiguration or repair.

Figure 4 illustrates the predicted OPB associated with the transceiver series specified in this data sheet at the Beginning of Life (BOL). These curves represent the attenuation and chromatic plus modal dispersion losses associated with the $62.5 / 125$ $\mu \mathrm{m}$ and $50 / 125 \mu \mathrm{~m}$ fiber cables only. The area under the curves represents the remaining OPB at any link length, which is available for overcoming non-fiber cable related losses.

Agilent LED technology has produced 1300 nm LED devices with lower aging characteristics than normally associated with these
technologies in the industry. The industry convention is 1.5 dB aging for 1300 nm LEDs. The Agilent Technologies 1300 nm LEDs will experience less than 1 dB of aging over normal commercial equipment mission life periods. Contact your Agilent sales representative for additional details.

Figure 4 was generated with an Agilent fiber optic link model containing the current industry conventions for fiber cable specifications and the FDDI PMD and LCF-PMD optical parameters. These parameters are reflected in the guaranteed performance of the transceiver specifications in this data sheet. This same model has been used extensively in the ANSI and IEEE committees, including the ANSI X3T9.5 committee, to establish the optical performance requirements for various fiber optic interface standards. The cable parameters used come from the ISO/IEC JTC1/SC 25/WG3

Generic Cabling for Customer Premises per DIS 11801 document and the EIA/TIA-568-A Commercial Building Telecommunications Cabling Standard per SP-2840.

## Transceiver Signaling Operating Rate Range and $B E R$ Performance

For purposes of definition, the symbol (Baud) rate, also called signaling rate, is the reciprocal of the shortest symbol time. Data rate (bits/sec) is the symbol rate divided by the encoding factor used to encode the data (symbols/bit).

When used in FDDI and ATM 100 Mbps applications the performance of the 1300 nm transceivers is guaranteed over the signaling rate of 10 MBd to 125 MBd to the full conditions listed in individual product specification tables.

The transceivers may be used for other applications at signaling rates outside of the 10 MBd to 125 MBd range with some penalty in the link


Figure 4. Optical Power Budget at BOL versus Fiber Optic Cable Length.
optical power budget primarily caused by a reduction of receiver sensitivity. Figure 5 gives an indication of the typical performance of these 1300 nm products at different rates.

These transceivers can also be used for applications which require different Bit Error Rate (BER) performance. Figure 6 illustrates the typical trade-off between link BER and the receivers input optical power level.

## Transceiver J itter Performance

The Agilent 1300 nm transceivers are designed to operate per the system jitter allocations stated in Tables E1 of Annexes E of the FDDI PMD and LCF-PMD standards.

The Agilent 1300 nm transmitters will tolerate the
worst case input electrical jitter allowed in these tables without violating the worst case output jitter requirements of Sections 8.1 Active Output Interface of the FDDI PMD and LCF-PMD standards.

The Agilent 1300 nm receivers will tolerate the worst case input optical jitter allowed in Sections 8.2 Active Input Interface of the FDDI PMD and LCF-PMD standards without violating the worst case output electrical jitter allowed in the Tables E1 of the Annexes E.

The jitter specifications stated in the following 1300 nm transceiver specification tables are derived from the values in Tables E1 of Annexes E. They represent the worst case jitter contribution that the transceivers are allowed to make to the overall system jitter
without violating the Annex E allocation example. In practice the typical contribution of the Agilent transceivers is well below these maximum allowed amounts.

## Recommended Handling Precautions

Agilent recommends that normal static precautions be taken in the handling and assembly of these transceivers to prevent damage which may be induced by electrostatic discharge (ESD). The AFBR5100Z series of transceivers meet MIL-STD-883C Method 3015.4 Class 2 products.

Care should be used to avoid shorting the receiver data or signal detect outputs directly to ground without proper current limiting impedance.


Figure 5. Transceiver Relative Optical Power Budget at Constant BER vs. Signaling Rate.


CONDITIONS:

1. 125 MBd
2. PRBS $2^{7}-1$
3. CENTER OF SYM BOL SAMPLING.
4. $\mathrm{T}_{\Delta}=25^{\circ} \mathrm{C}$

Figure 6. Bit Error Rate vs. Relative Receiver Input Optical Power.

## Solder and W ash Process Compatibility

The transceivers are delivered with protective process plugs inserted into the duplex SC or duplex ST connector receptacle.

This process plug protects the optical subassemblies during wave solder and aqueous wash processing and acts as a dust cover during shipping.

These transceivers are compatible with either industry standard wave or hand solder processes.

## Shipping Container

The transceiver is packaged in a shipping container designed to protect it from mechanical and ESD damage during shipment or storage.

## Board Layout - Decoupling Circuit and Ground Planes

It is important to take care in the layout of your circuit board to achieve optimum performance from these transceivers. Figure 7 provides a good example of a schematic for a power supply decoupling circuit that works well with these parts. It is further recommended that a contiguous ground plane be provided in the circuit board directly under the transceiver to provide a low inductance ground for signal return current. This recommendation is in keeping with good high frequency board layout practices.

## Board Layout - Hole Pattern

The Agilent transceiver complies with the circuit board "Common Transceiver Footprint" hole pattern defined in the original multisource announcement which defined
the $1 \times 9$ package style. This drawing is reproduced in Figure 8 with the addition of ANSI Y14.5M compliant dimensioning to be used as a guide in the mechanical layout of your circuit board.

## Board Layout - Mechanical

For applications providing a choice of either a duplex SC or a duplex ST connector interface, while utilizing the same pinout on the printed circuit board, the ST port needs to protrude from the


## NOTES:

THE SPLIT-LOAD TERMINATIONS FOR ECL SIGNALS NEED TO BE LOCATED AT THE INPUT OF DEVICES RECEIVING THOSE ECL SIGNALS. RECOMMEND 4-LAYER PRINTED CIRCUIT BOARD WITH 50 OHM MICROSTRIP SIGNAL PATHS BE USED.
$R 1=R 4=R 6=R 8=R 10=130$ OHMS.
$R 2=R 3=R 5=R 7=R 9=820 H M S$.
$\mathrm{C} 1=\mathrm{C} 2=\mathrm{C} 3=\mathrm{C} 5=\mathrm{C} 6=0.1 \mu \mathrm{~F}$.
$\mathrm{C} 4=10 \mu \mathrm{~F}$.
Figure 7. Recommended Decoupling and Termination Circuits

## Regulatory Compliance

These transceiver products are intended to enable commercial system designers to develop equipment that complies with the various international regulations governing certification of Information Technology Equipment. See the Regulatory Compliance Table for details. Additional information is available from your Agilent sales representative.

## Electrostatic Discharge (ESD)

There are two design cases in which immunity to ESD damage is important.
The first case is during handling of the transceiver prior to mounting it on the circuit board. It is important to use normal ESD handling precautions for ESD sensitive devices. These precautions
include using grounded wrist straps, work benches, and floor mats in ESD controlled areas.

The second case to consider is static discharges to the exterior of the equipment chassis containing the transceiver parts. To the extent that the duplex SC connector is exposed to the outside of the equipment chassis it may be subject to whatever ESD system level test criteria that the equipment is intended to meet.

## Electromagnetic Interference (EMI)

Most equipment designs utilizing these high speed transceivers from Agilent will be required to meet the requirements of FCC in the United States, CENELEC EN55022 (CISPR 22) in Europe and VCCI in Japan.

These products are suitable for use in designs ranging from a desktop computer with a single transceiver to a concentrator or switch product with a large number of transceivers.

In all well-designed chassis, two $0.5^{\prime \prime}$ holes for ST connectors to protrude through will provide 4.6 dB more shielding than one 1.2" duplex SC rectangular cutout. Thus, in a well-designed chassis, the duplex ST 1x9 transceiver emissions will be identical to the duplex SC 1x9 transceiver emissions.


TOP VIEW

## Figure 8. Recommended Board Layout Hole Pattern



Figure 8a. Recommended Common Mechanical Layout for SC and ST 1x9 Connectored Transceivers.


DIM ENSIONS ARE IN M ILLIM ETERS (INCHES).
ALL DIM ENSIONS ARE $\pm \mathbf{0 . 0 2 5} \mathbf{~ m m}$ UNLESS OTHERWISE SPECIFIED.

Figure 8b. Dimensions Shown for M ounting M odule with Extended Shield to Panel.

## Regulatory Compliance Table

| Feature | Test M ethod | Performance |
| :---: | :---: | :---: |
| Electrostatic Discharge (ESD) to the Electrical Pins | MIL-STD-883C <br> M ethod 3015.4 | M eets Class 2 (2000 to 3999 Volts) W ithstand up to 2200 V applied between electrical pins. |
| Electrostatic Discharge (ESD) to the Duplex SC Receptacle | Variation of IEC 801-2 | Typically withstand at least 25 kV without damage when the Duplex SC Connector Receptacle is contacted by a Human Body Model probe. |
| Electromagnetic Interference (EM C) | FCC Class B CENELEC CEN 55022 <br> Class B (CISPR 22B) VCCI Class 2 | Typically provide a 13 dB margin to the noted standards, how ever, it should be noted that final margin depends on the customer's board and chasis design. |
| Immunity | Variation of IEC 61000-4-3 | Typically show no measurable effect from a $10 \mathrm{~V} / \mathrm{m}$ field swept from 10 to 450 M Hz applied to the transceiver when mounted to a circuit card without a chassis enclosure. |



AFBR-5103Z FDDI TRANSMITTER TEST RESULTS
OF $I_{c}$, DI AND $t_{r / f}$ ARE CORRELATED AND
COM PLY WITH THE ALLOWED SPECTRAL WIDTH
AS A FUNCTION OF CENTER W AVELENGTH FOR
VARIOUS RISE AND FALL TIM ES.
Figure 9. Transmitter Output Optical Spectral Width (FW HM) vs. Transmitter Output Optical Center Wavelength and Rise/ Fall Times.

## Immunity

Equipment utilizing these transceivers will be subject to radio-frequency
electromagnetic fields in some environments. These transceivers have a high immunity to such fields.

For additional information regarding EMI, susceptibility, ESD and conducted noise testing procedures and results on the 1x9 Transceiver family, please refer to Applications Note 1075, Testing and Measuring Electromagnetic Compatibility Performance of the AFBR-510X/-520X Fiber Optic Transceivers.

## Transceiver Reliability and Performance Qualification Data

The 1x9 transceivers have passed Agilent reliability and performance qualification testing and are undergoing ongoing quality monitoring. Details are available from your Agilent sales representative.


THE AFBR-5103Z OUTPUT OPTICAL PULSE SHAPE SHALL FIT WITHIN THE BOUNDARIES OF THE PULSE ENVELOPE FOR RISE AND FALL TIM E M EASUREM ENTS.

Figure 10. Output Optical Pulse Envelope.

## Applications Support M aterials

Contact your local Agilent Component Field Sales Office for information on how to obtain PCB layouts, test boards and demo boards for the 1 x 9 transceivers.

## Evaluation Kits

Agilent has available three evaluation kits for the 1 x 9 transceivers. The purpose of these kits is to provide the necessary materials to evaluate the performance of the AFBR510XZ family in a pre-existing 1 x 13 or 2 x 11 pinout system design configuration or when connectored to various test equipment.

1. HFBR-0319 Evaluation Test Fixture Board
This test fixture converts +5 V ECL 1x9 transceivers to -5 V ECL BNC coax connections so that direct connections to industry standard fiber optic test equipment can be accomplished.

## Accessory Duplex SC Connectored Cable Assemblies

Agilent recommends for optimal coupling the use of flexible-body duplex SC connectored cable.

## Accessory Duplex ST Connectored Cable Assemblies

Agilent recommends the use of Duplex Push-Pull connectored cable for the most repeatable optical power coupling performance.


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CONDITIONS:
    1.TA}=2\mp@subsup{5}{}{\circ}\textrm{C
    2. VCC = 5 Vdc
    3. IN PUT OPTICAL RISE/ FALL TIM ES = 1.0/ 2.1 ns.
    4. IN PUT OPTICAL POW ER IS NORM ALIZED TO
        CENTER OF DATA SYMBOL.
    5. NOTE 20 AND 21 APPLY.
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Figure 11. Relative Input Optical Power vs. Eye Sampling Time Position.


Figure 12. Signal Detect Thresholds and Timing.

AFBR-5103Z Series
Absolute Maximum Ratings

| Parameter | Symbol | Min. | Typ. | Max. | Unit | Reference |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: |
| Storage Temperature | $\mathrm{T}_{\mathrm{S}}$ | -40 |  | 100 | ${ }^{\circ} \mathrm{C}$ |  |
| Lead Soldering Temperature | $\mathrm{T}_{\text {SoLD }}$ |  |  | 260 | ${ }^{\circ} \mathrm{C}$ |  |
| Lead Soldering Time | $\mathrm{t}_{\text {SoLD }}$ |  |  | 10 | sec. |  |
| Supply Voltage | $\mathrm{V}_{\mathrm{CC}}$ | -0.5 |  | 7.0 | V |  |
| Data Input Voltage | $\mathrm{V}_{\mathrm{L}}$ | -0.5 |  | $\mathrm{~V}_{\mathrm{CC}}$ | V |  |
| Differential Input Voltage | $\mathrm{V}_{\mathrm{D}}$ |  |  | 1.4 | V | Note 1 |
| Output Current | $\mathrm{I}_{0}$ |  |  | 50 | mA |  |

AFBR-5103Z Series
Recommended Operating Conditions*

| Parameter | Symbol | Min. | Typ. | Max. | Unit | Reference |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: |
| Ambient Operating Temperature | $\mathrm{T}_{\mathrm{A}}$ | 0 |  | 70 | ${ }^{\circ} \mathrm{C}$ |  |
| Supply Voltage | $\mathrm{V}_{\mathrm{CC}}$ | 4.75 |  | 5.25 | V |  |
| Data Input Voltage - Low | $\mathrm{V}_{\mathrm{IL}}-\mathrm{V}_{\mathrm{CC}}$ | -1.810 |  | -1.475 | V |  |
| Data Input Voltage - High | $\mathrm{V}_{\mathrm{H}}-\mathrm{V}_{\mathrm{CC}}$ | -1.165 |  | -0.880 | V |  |
| Data and Signal Detect Output Load | $\mathrm{R}_{\mathrm{L}}$ |  | 50 |  | y | Note 2 |

*Applies to AFBR-5103Z \& AFBR-5103TZ \& AFBR-5103PZ/ -5103PEZ Series except forAFBR-5103AZ/ -5103ATZ. T. for
AFBR-5103AZ/ $-5103 A T Z$ is $-40^{\circ} \mathrm{C}$ and $85^{\circ} \mathrm{C}$.
Transmitter Electrical Characteristics*
( $\mathrm{T}_{\mathrm{A}}=0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CC}}=4.75 \mathrm{~V}$ to 5.25 V )

| Parameter | Symbol | Min. | Typ. | Max. | Unit | Reference |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: |
| Supply Current | $I_{\text {CC }}$ |  | 145 | 185 | mA | Note 3 |
| Power Dissipation | $\mathrm{P}_{\mathrm{DIS}}$ |  | 0.76 | 0.97 | W |  |
| Data Input Current - Low | $\mathrm{I}_{\mathrm{IL}}$ | -350 | 0 |  | $\mu \mathrm{~A}$ |  |
| Data Input Current - High | $\mathrm{I}_{\mathrm{IH}}$ |  | 14 | 350 | $\mu \mathrm{~A}$ |  |

*Applies to AFBR-5103Z \& AFBR 5103TZ \& AFBR-5103PZ/ -5103PEZ Series except for AFBR-5103AZ/ -5103ATZ. T. for AFBR-5103AZ/ $-5103 A T Z$ is $-40^{\circ} \mathrm{C}$ and $85^{\circ} \mathrm{C}$..

## Receiver Electrical Characteristics

( $\mathrm{T}_{\mathrm{A}}=0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CC}}=4.75 \mathrm{~V}$ to 5.25 V )*

| Parameter | Symbol | Min. | Typ. | Max. | Unit | Reference |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: |
| Supply Current | $\mathrm{I}_{\mathrm{CC}}$ |  | 82 | 145 | mA | Note 4 |
| Power Dissipation | $\mathrm{P}_{\mathrm{DISS}}$ |  | 0.3 | 0.5 | W | Note 5 |
| Data Output Voltage - Low | $\mathrm{V}_{\mathrm{OL}}-\mathrm{V}_{\mathrm{CC}}$ | -1.83 |  | -1.55 | V | Note 6 |
| Data Output Voltage - High | $\mathrm{V}_{\text {OH }}-\mathrm{V}_{\mathrm{CC}}$ | -1.085 |  | -0.88 | V | Note 6 |
| Data Output Rise Time | $\mathrm{t}_{\mathrm{r}}$ | 0.35 |  | 2.2 | ns | Note 7 |
| Data Output Fall Time | $\mathrm{t}_{\mathrm{f}}$ | 0.35 |  | 2.2 | ns | Note 7 |
| Signal Detect Output Voltage - Low | $\mathrm{V}_{\text {OL }}-\mathrm{V}_{\mathrm{CC}}$ | -1.83 |  | -1.55 | V | Note 6 |
| Signal Detect Output Voltage - High | $\mathrm{V}_{\text {OH }}-\mathrm{V}_{\mathrm{CC}}$ | -1.085 |  | -0.88 | V | Note 6 |
| Signal Detect Output Rise Time | $\mathrm{t}_{\mathrm{r}}$ | 0.35 |  | 2.2 | ns | Note 7 |
| Signal Detect Output Fall Time | $\mathrm{t}_{\mathrm{f}}$ | 0.35 |  | 2.2 | ns | Note 7 |

[^0]AFBR-5103Z/-5103TZ
Transmitter Optical Characteristics
( $\mathrm{T}_{\mathrm{A}}=0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CC}}=4.75 \mathrm{~V}$ to 5.25 V )

| Parameter |  | Symbol | Min. | Typ. | Max. | Unit | Reference |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Output Optical Power $62.5 / 125 \mu \mathrm{~m}, \mathrm{NA}=0.275$ Fiber | $\begin{aligned} & \hline \mathrm{BOL} \\ & \mathrm{EOL} \end{aligned}$ | $\mathrm{P}_{0}$ | $\begin{aligned} & \hline-19 \\ & -20 \end{aligned}$ | -16.8 | -14 | dBm avg. | Note 11 |
| Output Optical Power $50 / 125 \mu \mathrm{~m}, \mathrm{NA}=0.20$ Fiber | $\begin{aligned} & \text { BOL } \\ & \text { EOL } \end{aligned}$ | $P_{0}$ | $\begin{aligned} & -22.5 \\ & -23.5 \end{aligned}$ | -20.3 | -14 | dBm avg. | Note 11 |
| Optical Extinction Ratio |  |  |  |  | $\begin{gathered} 10 \\ -10 \end{gathered}$ | $\begin{aligned} & \% \\ & \mathrm{~dB} \end{aligned}$ | Note 12 |
| Output Optical Power at Logic "0" State |  | $\mathrm{P}_{0}\left({ }^{\prime \prime}{ }^{\prime \prime}\right)$ |  |  | -45 | dBm avg. | Note 13 |
| Center W avelength |  | $I_{C}$ | 1270 | 1308 | 1380 | nm | Note 14 <br> Figure 9 |
| Spectral Width - FWHM |  | Đ1 |  | 137 | 200 | nm | Note 14 Figure 9 |
| Optical Rise Time |  | $\mathrm{t}_{\mathrm{r}}$ | 0.6 | 1.0 | 3.0 | ns | Note 14, 15 <br> Figure 9, 10 |
| Optical Fall Time |  | $\mathrm{t}_{\mathrm{f}}$ | 0.6 | 2.1 | 3.0 | ns | Note 14, 15 <br> Figure 9, 10 |
| Duty Cycle Distortion Contributed by the Transmitter |  | DCD |  | 0.02 | 0.6 | ns p-p | Note 16 |
| Data Dependent Jitter Cobntributed by the Transmitter |  | DDJ |  | 0.02 | 0.6 | ns p-p | Note 17 |

AFBR-5103Z/ -5103TZ
Receiver Optical and Electrical Characteristics
( $\mathrm{T}_{\mathrm{A}}=0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CC}}=4.75 \mathrm{~V}$ to 5.25 V )

| Parameter | Symbol | Min. | Typ. | Max. | Unit | Reference |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Input Optical Power Minimum at W indow Edge | $\mathrm{P}_{\text {INMin. }}$ (W) |  | -33.5 | -31 | dBm avg. | Note 19 Figure 11 |
| Input Optical Power Minimum at Eye Center | $\mathrm{P}_{\text {INMin. }}$ (C) |  | -34.5 | -31.8 | dBm avg. | Note 20 Figure 11 |
| Input Optical Power M aximum | Pinmax. | -14 | -11.8 |  | dBm avg. | Note 19 |
| Operating W avelength | I | 1270 |  | 1380 | nm |  |
| Duty Cycle Distortion Contributed by the Receiver | DCD |  | 0.02 | 0.4 | ns p-p | Note 8 |
| Data Dependent J itter Contributed by the Receiver | DDJ |  | 0.35 | 1.0 | ns p-p | Note 9 |
| Random J itter Contributed by the Receiver | RJ |  | 1.0 | 2.14 | ns p-p | Note 10 |
| Signal Detect - Asserted | $\mathrm{P}_{\mathrm{A}}$ | $\mathrm{P}_{\mathrm{D}}+1.5 \mathrm{~dB}$ |  | -33 | dBm avg. | Note 21, 22 Figure 12 |
| Signal Detect - Deasserted | $P_{\text {D }}$ | -45 |  |  | dBm avg. | Note 23, 24 Figure 12 |
| Signal Detect - Hysteresis | $P_{A}-P_{D}$ | 1.5 | 2.4 |  | dB | Figure 12 |
| Signal Detect Assert Time (off to on) | AS_Max | 0 | 55 | 100 | $\mu \mathrm{s}$ | Note 21, Figure 12 |
| SignalDetectAssert Time (off to on) for $-40^{\circ} \mathrm{C}$ to $0^{\circ} \mathrm{C}$ | AS_Max | 0 | 55 | 130 | $\mu \mathrm{s}$ | Note 21, Figure 12 |
| Signal Detect Deassert Time (onto off) | ANS_Max | 0 | 110 | 350 | $\mu \mathrm{s}$ | Note 23, 24 Figure 12 |

Notes:

1. This is the maximum voltage that can be applied across the Differential Transmitter Data Inputs to prevent damage to the input ESD protection circuit.
2. The outputs are terminated with $50 y$ connected to $\mathrm{V}_{\text {cc }}-2 \mathrm{~V}$.
3. The power supply current needed to operate the transmitter is provided to differential ECL circuitry. This circuitry maintains a nearly constant current flow from the power supply. Constant current operation helps to prevent unwanted electrical noise from being generated and conducted or emitted to neighboring circuitry.
4. This value is measured with the outputs terminated into 50 ý connected to $\mathrm{V}_{\mathrm{CC}}-2 \mathrm{~V}$ and an Input Optical Power level of -14 dBm average.
5. The power dissipation value is the power dissipated in the receiver itself. Power dissipation is calculated as the sum of the products of supply voltage and currents, minus the sum of the products of the output voltages and currents.
6. These values are measured with respect to $V_{C C}$ with the output terminated into 50 ý connected to $\mathrm{V}_{\text {CC }}-2 \mathrm{~V}$.
7. The output rise and fall times are measured between $20 \%$ and $80 \%$ levels with the output connected to $\mathrm{V}_{\mathrm{CC}}-2 \mathrm{~V}$ through 50 ý.
8. Duty Cycle Distortion contributed by the receiver is measured at the $50 \%$ threshold using an IDLE Line State, 125 M Bd ( 62.5 M Hzsquare-wave), input signal. The input optical power level is -20 dBm average. See Application Information - TransceiverJ Itter Section for further information.
9. Data Dependent J itter contributed by the receiver is specified with the FDDI DDJ test pattern described in the FDDI PM D Annex A.5. The input optical power level is -20 dBm average. See Application Information Transceiver J itter Section for further information.
10. Random J itter contributed by the receiver is specified with an IDLE Line State, 125 M Bd ( $62.5 \mathrm{M} \mathrm{Hzsquare-wave)} ,\mathrm{input} \mathrm{signal}$. input optical power level is at maximum "PIN Min. (W)". See Application Information Transceiver J itter Section for further information.
11. These optical power values are measured with the following conditions:

- The Beginning of Life ( BOL ) to the End of Life (EOL) optical power degradation is typically 1.5 dB per the industry convention for long wavelength LEDs. The actual degradation observed in Agilent's 1300 nm LED products is $<1 \mathrm{~dB}$, as specified in this data sheet.
- Over the specified operating voltage and temperature ranges.
- W ith HALT Line State, ( 12.5 M Hz squarewave), inputsignal.
- At the end of one meter of noted optical fiber with cladding modes removed.
The average power value can be converted to a peak power value by adding 3 dB . Higher output optical power transmitters are available on special request.

12. The Extinction Ratio is a measure of the modulation depth of the optical signal. The data "0" output optical power is compared to the data " 1 " peak output optical power and expressed as a percentage. With the transmitter driven by a HALT Line State ( 12.5 M Hz square-wave) signal, the average optical power is measured. The data " 1 " peak power is then calculated by adding 3 $d B$ to the measured average optical power. The data " 0 " output optical power is found by measuring the optical power when the transmitter is driven by a logic " 0 " input. The extinction ratio is the ratio of the optical power at the " 0 " level compared to the optical power at the " 1 " level expressed as a percentage or in decibels.
13. The transmitter provides compliance with the need for Transmit_Disable commands from the FDDI SM T layer by providing an Output Optical Power level of <-45 dBm average in response to a logic " 0 " input. This specification applies to either 62.5/ 125 $\mu \mathrm{m}$ or $50 / 125 \mu \mathrm{~m}$ fiber cables.
14. This parameter complies with the FDDI PM D requirements for the tradeoffs betw een center wave-length, spectral width, and rise/ fall times shown in Figure 9.
15. This parameter complies with the optical pulse envelope from the FDDI PM D shown in Figure 10. The optical rise and fall times are measured from $10 \%$ to $90 \%$ when the transmitter is driven by the FDDI HALT Line State ( 12.5 M Hz square-wave) input signal.
16. Duty Cycle Distortion contributed by the transmitter is measured at a $50 \%$ threshold using an IDLE Line State, 125 M Bd ( 62.5 M Hz square-wave), input signal. See Application Information - TransceiverJ Itter Performance Section of this data sheet for further details.
17. Data Dependent Jitter contributed by the transmitter is specified with the FDDI test pattern described in FDDI PM D Annex A.5. See A pplication Information - Transceiver $J$ itter Performance Section of this data sheet for further details.
18. Random J itter contributed by the transmitter is specified with an IDLE Line State, 125 M Bd ( 62.5 M Hz square-wave), input signal. See Application Information Transceiver Jitter Performance Section of this data sheet for further details.
19. This specification is intended to indicate the performance of the receiver section of the transceiver when Input Optical Power signal characteristics are present per the following definitions. The Input Optical Power dynamic range from the minimum level (with a window time-width) to the maximum level is the range over which the receiver is guaranteed to provide output data with a Bit Error Ratio (BER) better than or equal to $2.5 \times 10^{-10}$.

- At the Beginning of Life (BOL)
- Over the specified operating temperature and voltage ranges
- Input symbol pattern is the FDDI test pattern defined in FDDI PM D Annex A. 5 with 4B/ 5B NRZI encoded data that contains a duty cycle base-line wander effect of 50 kHz . This sequence causes a near worst case condition for inter-symbol interference.
- Receiver data window time-width is 2.13 ns or greater and centered at mid-symbol. This worst case window time-width is the minimum allow ed eye-opening presented to the FDDI PHY PM ._Data indication input (PHY input) per the example in FDDI PM D Annex E. This minimum window time-width of 2.13 ns is based upon the worst case FDDI PM D Active Input Interface optical conditions for peak-to-peak $\operatorname{DCD}(1.0 \mathrm{~ns})$, DDJ ( 1.2 ns ) and RJ ( 0.76 ns ) presented to the receiver.
To test a receiver with the worst case FDDI PM D Active Input jitter condition requires exacting control over DCD, DDJ and RJ jitter components that is difficult to implement with production test equipment. The receiver can be equivalently tested to the worst case FDDI PM D input jitter conditions and meet the minimum output data window time-width of 2.13 ns . This is accomplished by using a nearly ideal input optical signal ( $n o$ DCD, insignificant DDJ and RJ) and measuring for a wider window time-width of 4.6 ns . This is possible due to the cumulative effect of jitter components through their superposition (DCD and DDJ are directly additive and RJ components are rms additive). Specifically, when a nearly ideal input optical test signal is used and the maximum receiver peak-to-peak jitter contributions of $\operatorname{DCD}(0.4 \mathrm{~ns}), D D J(1.0 \mathrm{~ns})$, and RJ ( 2.14 ns ) exist, the minimum window time-width becomes $8.0 \mathrm{~ns}-0.4 \mathrm{~ns}-1.0 \mathrm{~ns}$ $2.14 \mathrm{~ns}=4.46 \mathrm{~ns}$, or conservatively 4.6 ns . This wider window time-width of 4.6 ns guarantees the FDDI PM D Annex E minimum window time-width of 2.13 ns
under worst case input jitter conditions to the Agilent receiver.
- Transmitter operating with an IDLE Line State pattern, 125 M Bd ( 62.5 M Hz square-wave), input signal to simulate any cross-talk present betw een the transmitter and receiver sections of the transceiver.

20. All conditions of Note 19 apply except that the measurement is made at the center of the symbol with no window time-width.
21. This value is measured during the transition from low to high levels of input optical power.
22. The Signal Detect output shall be asserted within $100 \mu \mathrm{~s}\left(130 \mu \mathrm{~s}\right.$ for $-40^{\circ} \mathrm{C}$ to $\left.0^{\circ} \mathrm{C}\right)$ after a step increase of the Input Optical Power. The step will be from a low Input Optical Power, -45 dBm , into the range betw een greater than $\mathrm{P}_{\mathrm{A}}$, and -14 dBm . The BER of the receiver output will be $10^{-2}$ or better during the time, LS_Max ( $15 \mu \mathrm{~s}$ ) after Signal Detect has been asserted. See Figure 12 for more information.
23. This value is measured during the transition from high to low levels of input optical power. The maximum value will occur when the input optical power is either -45 dBm average or when the input optical power yields a BER of $10^{-2}$ or better, whichever power is higher.
24. Signal detect output shall be de-asserted within $350 \mu \mathrm{~s}$ after a step decrease in the Input Optical Power from a level which is the lower of; -31 dBm or $P_{D}+4 \mathrm{~dB}$ ( $P_{D}$ is the power level at which signal detect was deasserted), to a power level of -45 dBm or less. This step decrease will have occurred in less than 8 ns . The receiver output will have a $B E R$ of $10^{-2}$ or better for a period of $12 \mu \mathrm{~s}$ or until signal detect is deasserted. The input data stream is the Quiet Line State. Also, signal detect will be deasserted within a maximum of $350 \mu \mathrm{~s}$ after the BER of the receiver output degrades above $10^{-2}$ for an input optical data stream that decays with a negative ramp function instead of a step function. See Figure 12 for more information.

## Ordering Information:

1300 nm LED, 125 M Bd, FDDI, 100 M bps ATM and Fast Eternet temperature range $0^{\circ} \mathrm{C}$ to $+70^{\circ} \mathrm{C}$

AFBR-5103Z Duplex SC Connector 1X9, Standard Height
AFBR-5103TZ Duplex ST Connector 1X9
AFBR-5103PZ Duplex SC Connector 1x9, M ezzanine Height
AFBR-5103PEZ Duplex SC Connector 1x9, M ezzanine Height with Extended Shield
1300nm LED, 125 M Bd, FDDI, 100 M bps ATM and Fast Ethernet temperature range $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$
AFBR-5103AZ Duplex SC Connector 1X9
AFBR-5103ATZ Duplex ST Connector 1X9

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Hong Kong: (+65) 67562394
India, Australia, New Zealand: (+65) 67551939
J apan: (+81 3) 3335-8152(Domestic/ Inter-
national), or 0120-61-1280(Domestic Only)
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[^0]:    *A pplies to AFBR-5103Z \& AFBR 5103TZ \& AFBR-5103PZ and 5103PEZ Series except for AFBR-5103AZI -5103ATZ. TA for AFBR-5103AZI $-5103 A T Z$ is $-40^{\circ} \mathrm{C}$ and $85^{\circ} \mathrm{C}$.

